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Application/Control No.	Applicant(s)/Patent under Reexamination
10/000,415	KOLZE ET AL.
Examiner	Art Unit

Pankaj Kumar

2611

SEARCHED				
Class	Subclass	Date	Examiner	
375	224, 226, 227, 228, 316, 340	7/30/2007	PK	
375	341, 377	7/30/2007	PK _.	
375	346	7/30/2007	PK	
455	500, 296	7/30/2007	PK	
455	67.13,.11	7/30/2007	PK .	
455	39,63.1	7/30/2007	PK	
455	130, 334	7/30/2007	PK	
455	501	7/30/2007	PK	
714	699, 704	7/30/2007	PK .	

INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner
375	340	7/30/2007	PK .
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SEAF (INCLUDING S	RCH NOT SEARCH S	ES STRATEGY)
	!	DATE	EXMR
EAST		7/30/2007	PK
IEEE		7/30/2007	РК
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